

# 1200V 40mΩ Silicon Carbide Power MOSFET

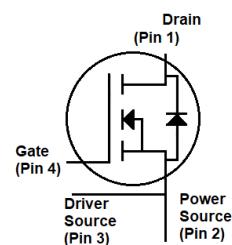
## Features

- High blocking voltage with low on-resistance
- High switching speed with low capacitance
- Very fast and robust intrinsic body diode with low reverse recovery
- Very low switching losses
- Excellent avalanche ruggedness
- RoHS compliant



## Benefits

- Greater system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency
- Easy to parallel and simple to drive



## Potential Applications

Package Type: TO-247-4L

- Solar inverters
- Uninterrupted power supplies
- Switch mode power supplies
- Motor drives



## Description

The Sanan Semiconductor 1200V/40mΩ silicon carbide power MOSFET uses advanced SiC MOSFET technology with low on-resistance, low switching losses, and a high operation temperature of 175°C. It is suitable for use in high frequency circuits and provides a reduction in overall system size, increased efficiency and increased switching frequency. It has been widely used in applications including solar inverters, uninterrupted power supplies, switch mode power supplies, and motor drives. Using RoHS compliant components, it is qualified for use in industrial application.

## Product Specifications

Device	V <sub>DS</sub>	I <sub>D</sub> (25°C)	R <sub>(DS)on</sub>	Marking
SMS1200040M2	1200V	48A	40mΩ	MS1200040M2

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**Table 1. Maximum Ratings**(T<sub>c</sub> = 25°C, unless otherwise specified)

Parameter	Symbol	Value	Unit	Test conditions	
Drain-source voltage	V <sub>DSmax</sub>	1200	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 100µA	
Gate-source voltage, max. transient voltage	V <sub>GSmax</sub>	-10/+25		t <sub>p</sub> ≤ 0.5us, D < 1%	
Gate-source voltage, max. static voltage	V <sub>GSmax</sub>	-8/+22			
Gate-source voltage	V <sub>GSop</sub>	-5/+18		Recommended operation values	
Continuous drain current	I <sub>D</sub>	48	A	V <sub>GS</sub> = 18V	
		34		V <sub>GS</sub> = 18V, T <sub>c</sub> = 100°C	
Pulsed drain current	I <sub>D(pulse)</sub>	120	A	Pulse width t <sub>p</sub> limited by T <sub>jmax</sub>	
Power dissipation	P <sub>tot</sub>	240	W		
Operating junction temperature	T <sub>j</sub>	-55~175	°C		
Storage temperature	T <sub>stg</sub>	-55~175	°C		
Soldering temperature	T <sub>L</sub>	260	°C	1.6mm from case for 10s	
Mounting torque	M	0.7	Nm	M3 screw	

**Table 2. Thermal Resistances**

Parameter	Symbol	Values			Unit	Test condition
		Min.	Typ.	Max.		
Thermal resistance from junction to case	R <sub>th(j-c)</sub>	/	0.52	/	°C/W	
Thermal resistance from junction to ambient	R <sub>th(j-a)</sub>	/	/	40	°C/W	

**Table 3. Static Electrical Characteristics**(T<sub>j</sub> = 25°C, unless otherwise specified)

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	1200	/	/		V <sub>GS</sub> = 0V, I <sub>D</sub> = 100µA
Gate threshold voltage	V <sub>GS(th)</sub>	1.8	3.0	4.2	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 7mA
		/	2.2	/		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 7mA, T <sub>j</sub> = 175°C
Drain-source leakage current	I <sub>DSS</sub>	/	1	150	µA	V <sub>DS</sub> = 1200V, V <sub>GS</sub> = 0V
Gate-source leakage current	I <sub>GSS</sub>	/	1	250	nA	V <sub>GS</sub> = 18V, V <sub>DS</sub> = 0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	/	46	/	mΩ	V <sub>GS</sub> = 15V, I <sub>D</sub> = 22A
		/	40	56		V <sub>GS</sub> = 18V, I <sub>D</sub> = 22A
		/	66	/		V <sub>GS</sub> = 18V, I <sub>D</sub> = 22A, T <sub>j</sub> = 175°C
Transconductance	g <sub>fs</sub>	/	12	/	S	V <sub>DS</sub> = 20V, I <sub>D</sub> = 22A
		/	14	/		V <sub>DS</sub> = 20V, I <sub>D</sub> = 22A, T <sub>j</sub> = 175°C
Internal gate resistance	R <sub>g(int)</sub>	/	4.4	/	Ω	f = 1MHz, V <sub>AC</sub> = 25mV

**Table 4. Dynamic Electrical Characteristics**(T<sub>j</sub> = 25°C, unless otherwise specified)

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Input capacitance	C <sub>iss</sub>	/	1641	/		
Output capacitance	C <sub>oss</sub>	/	70	/	pF	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 1000V, f = 1MHz, V <sub>AC</sub> = 25mV
Reverse transfer capacitance	C <sub>rss</sub>	/	3	/		
C <sub>oss</sub> stored energy	E <sub>oss</sub>	/	40	/	µJ	
Gate to source charge	Q <sub>GS</sub>	/	23	/	nC	V <sub>DD</sub> = 800V, V <sub>GS</sub> = -5/+18V, I <sub>D</sub> = 22A, I <sub>GS</sub> = 1mA
Gate to drain charge	Q <sub>GD</sub>	/	20	/		
Total gate charge	Q <sub>G</sub>	/	72	/		

## Table 5. Switching Characteristics

( $T_j = 25^\circ\text{C}$ , unless otherwise specified)

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Turn-on delay time	$t_{d(on)}$	/	13	/	ns	$V_{DD} = 800\text{V}$ , $V_{GS} = -5/+18\text{V}$ , $I_D = 22\text{A}$ , $R_{G(ext)} = 2.4\Omega$ , $L = 110\mu\text{H}$
Rise time	$t_r$	/	15	/		
Turn-off delay time	$t_{d(off)}$	/	27	/		
Fall time	$t_f$	/	15	/		
Turn-on switching energy	$E_{on}$	/	252	/	$\mu\text{J}$	$V_{DD} = 800\text{V}$ , $V_{GS} = -5/+18\text{V}$ , $I_D = 22\text{A}$ , $R_{G(ext)} = 2.4\Omega$ , $L = 110\mu\text{H}$ , $T_j = 175^\circ\text{C}$
Turn-off switching energy	$E_{off}$	/	17	/		
Turn-on delay time	$t_{d(on)}$	/	11	/		
Rise time	$t_r$	/	17	/		
Turn-off delay time	$t_{d(off)}$	/	33	/	$\mu\text{J}$	$V_{DD} = 800\text{V}$ , $V_{GS} = -5/+18\text{V}$ , $I_D = 22\text{A}$ , $R_{G(ext)} = 2.4\Omega$ , $L = 110\mu\text{H}$ , $T_j = 175^\circ\text{C}$
Fall time	$t_f$	/	15	/		
Turn-on switching energy	$E_{on}$	/	320	/		
Turn-off switching energy	$E_{off}$	/	18	/		

**Table 6. Reverse SiC Diode Characteristics**
 $(T_j = 25^\circ\text{C}, \text{unless otherwise specified})$ 

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Diode forward voltage	$V_{SD}$	/	4.25	/	V	$V_{GS} = -5V, I_{SD} = 22A$
		/	3.70	/		$V_{GS} = -5V, I_{SD} = 22A, T_j = 175^\circ\text{C}$
Continuous diode forward current	$I_S$	/	/	48	A	$T_C = 25^\circ\text{C}$
Diode pulse current	$I_{S, \text{pulse}}$	/	/	120	A	$V_{GS} = -5V, \text{pulse width } t_p \text{ limited by } T_{j\max}$
Reverse recovery time	$t_{rr}$	/	13	/	ns	$V_{GS} = -5V, I_{SD} = 22A, V_R = 800V, \frac{dI}{dt} = 3.01\text{kA}/\mu\text{s}$
Reverse recovery charge	$Q_{rr}$	/	0.3	/	$\mu\text{C}$	
Peak reverse recovery current	$I_{rrm}$	/	38	/	A	
Reverse recovery time	$t_{rr}$	/	20	/	ns	
Reverse recovery charge	$Q_{rr}$	/	0.62	/	$\mu\text{C}$	$V_R = 800V, T_j = 175^\circ\text{C}, \frac{dI}{dt} = 2.98\text{kA}/\mu\text{s}$
Peak reverse recovery current	$I_{rrm}$	/	52	/	A	

## Electrical Characteristic Diagrams

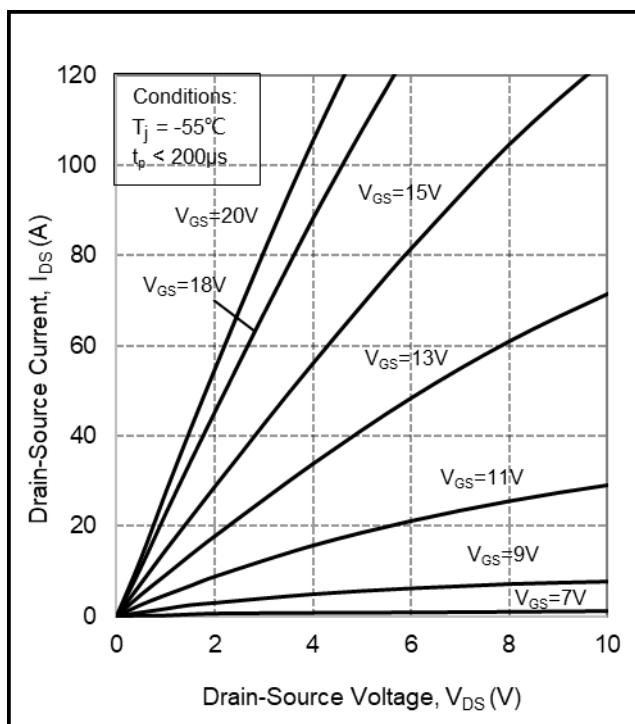


Figure 1. Output characteristics at  $T_j = -55^\circ\text{C}$

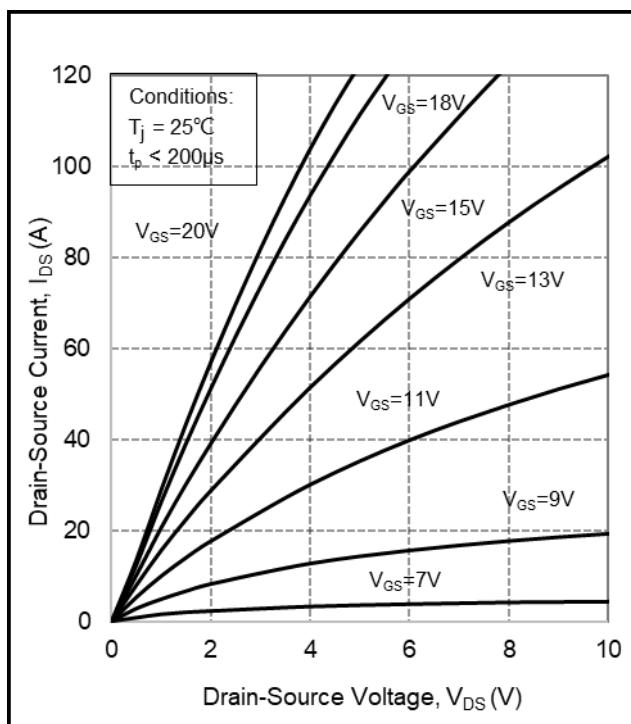


Figure 2. Output characteristics at  $T_j = 25^\circ\text{C}$

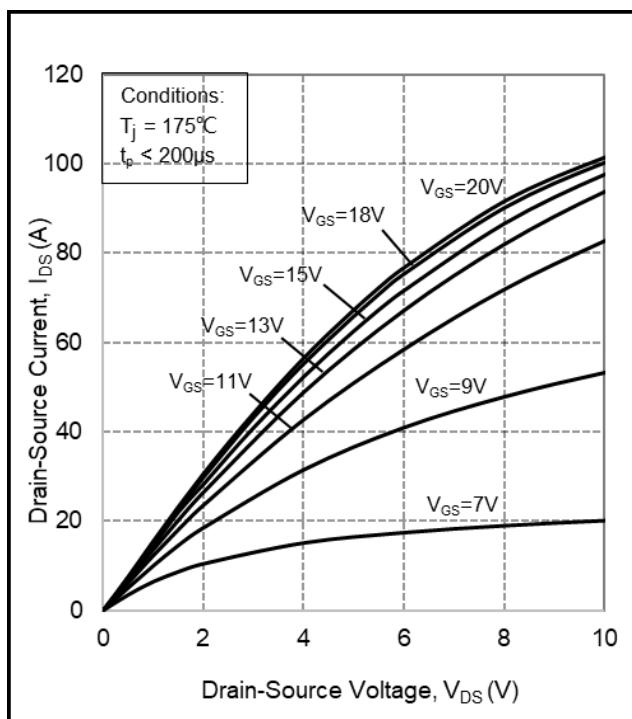


Figure 3. Output characteristics at  $T_j = 175^\circ\text{C}$

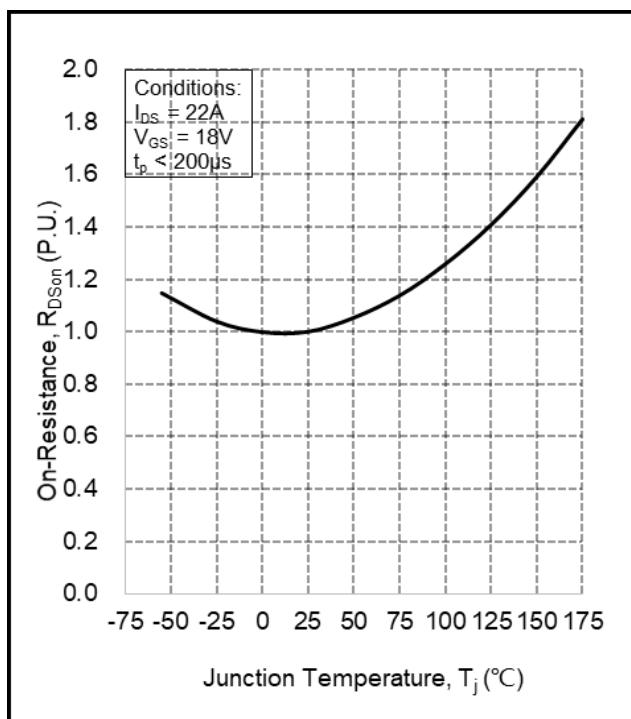
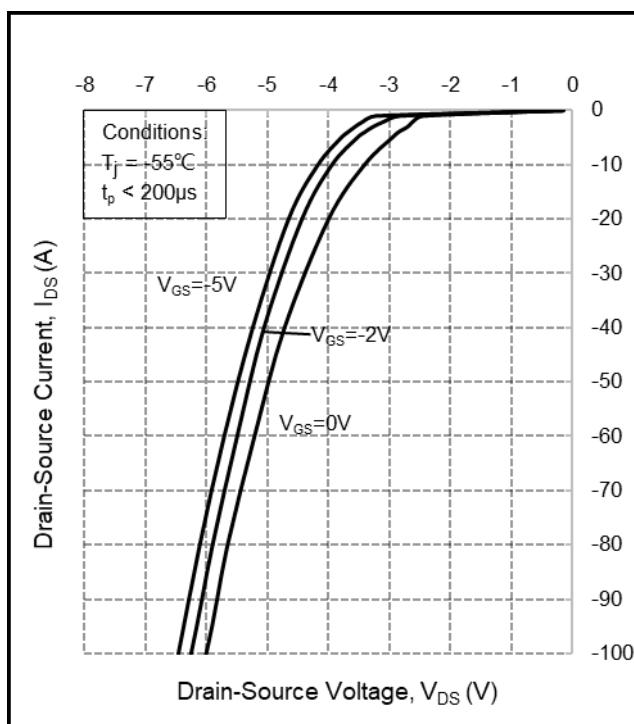
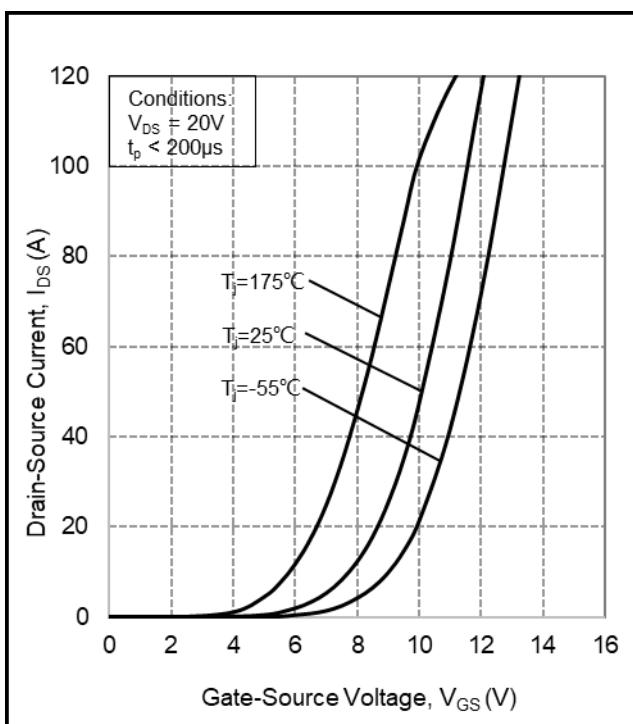
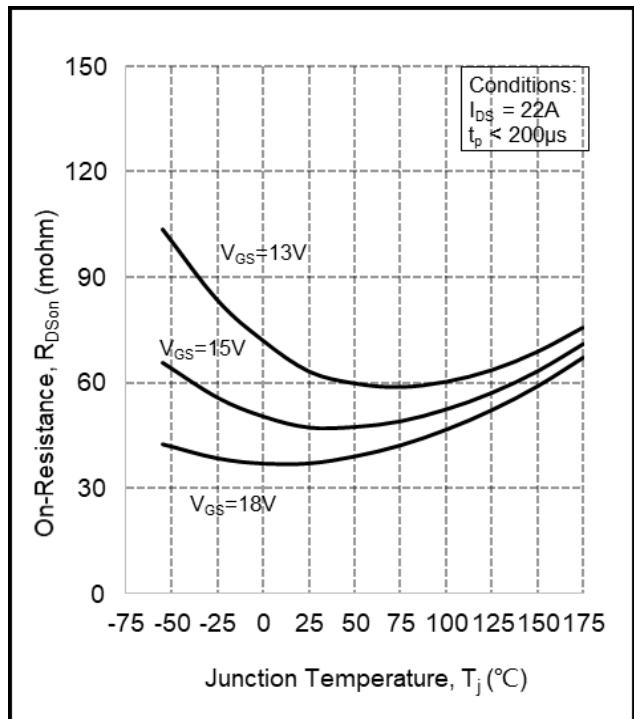
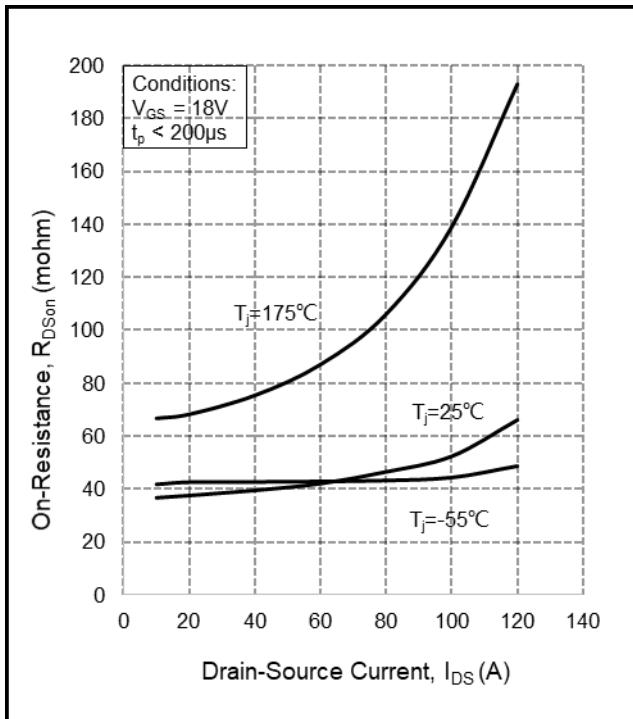


Figure 4. Normalized on-resistance vs. temperature



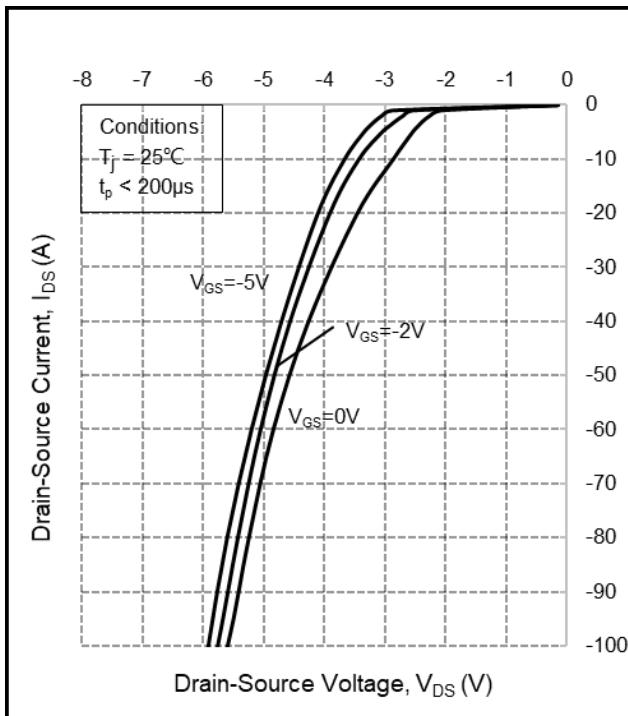
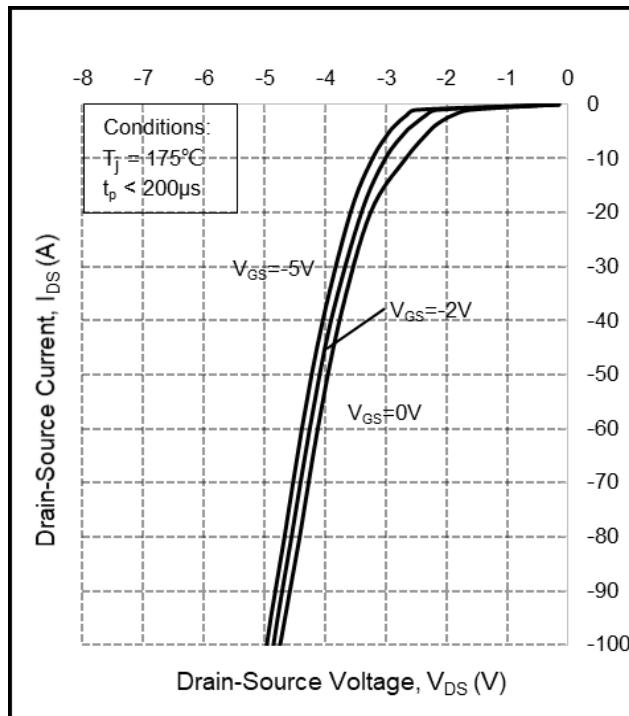
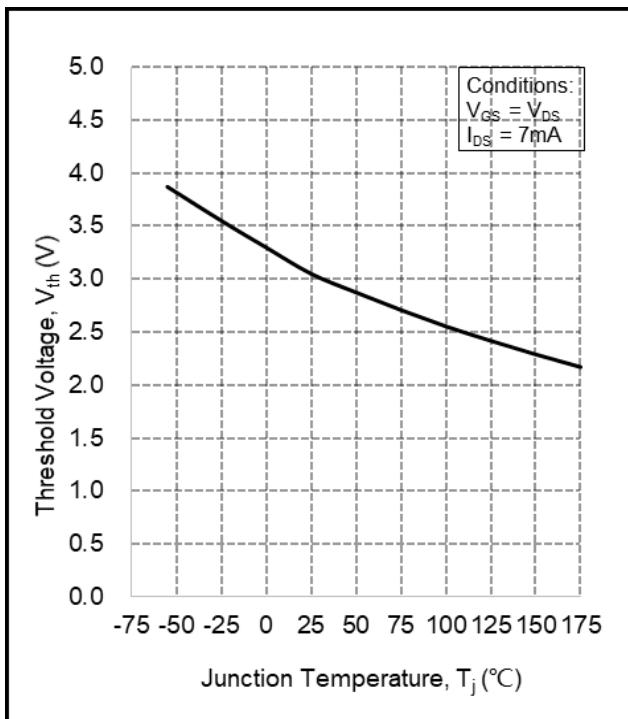

 Figure 9. Body diode characteristic at  $T_j = 25^\circ\text{C}$ 

 Figure 10. Body diode characteristic at  $T_j = 175^\circ\text{C}$ 


Figure 11. Threshold voltage vs. temperature

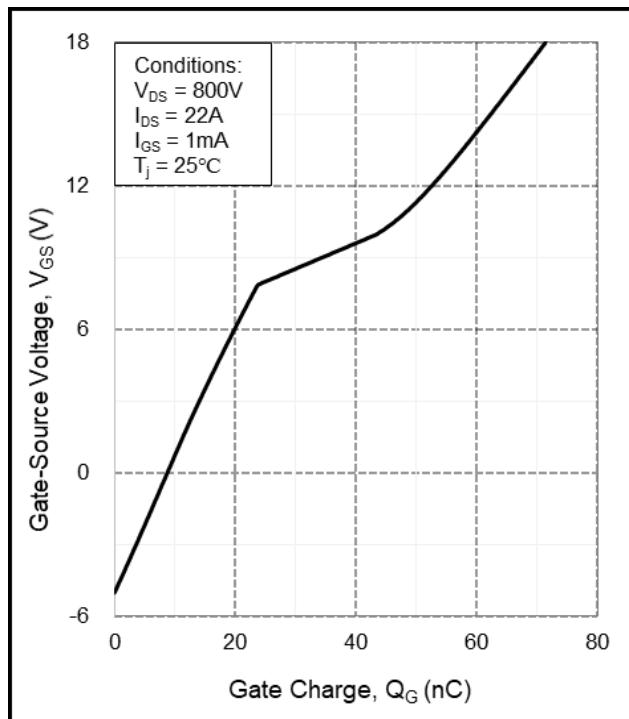


Figure 12. Gate charge characteristics

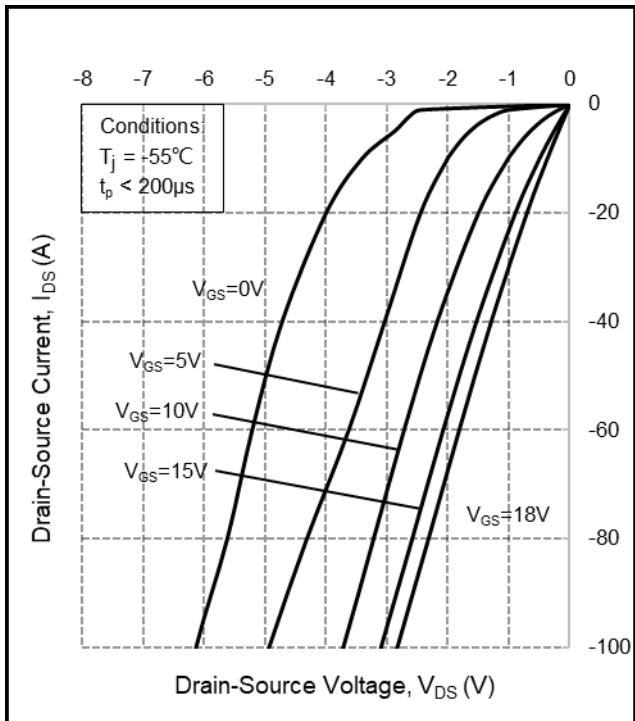


Figure 13. 3rd quadrant characteristic  
 at  $T_j = -55^\circ\text{C}$

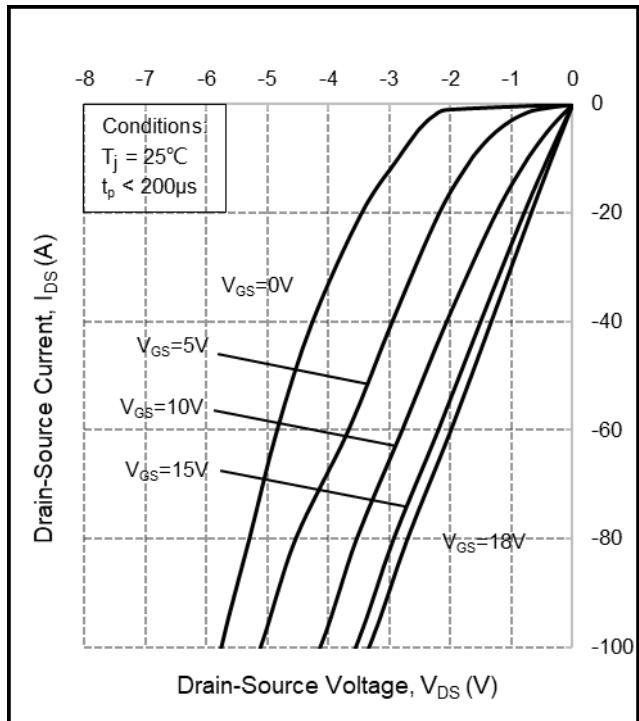


Figure 14. 3rd quadrant characteristic  
 at  $T_j = 25^\circ\text{C}$

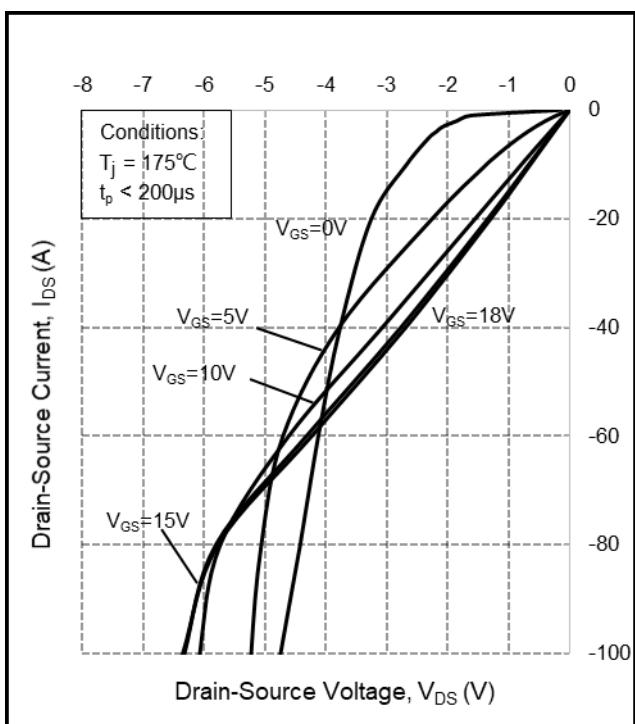


Figure 15. 3rd quadrant characteristic  
 at  $T_j = 175^\circ\text{C}$

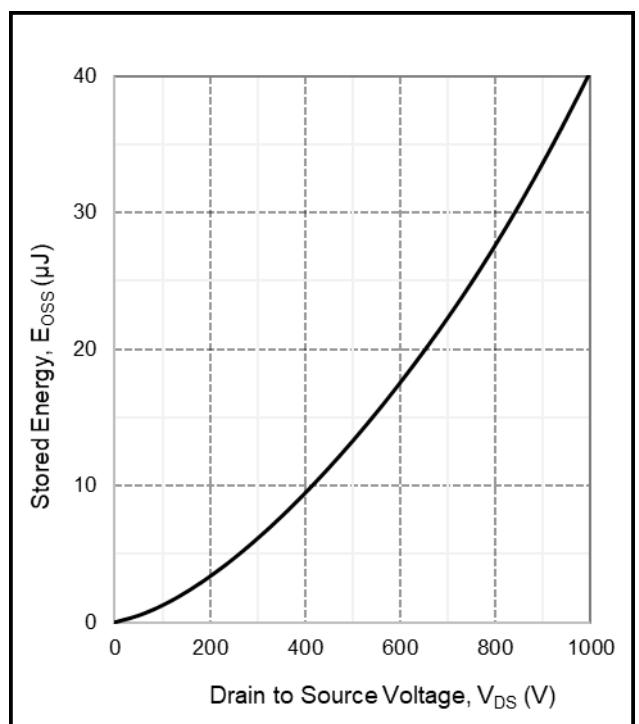


Figure 16. Output capacitor stored energy

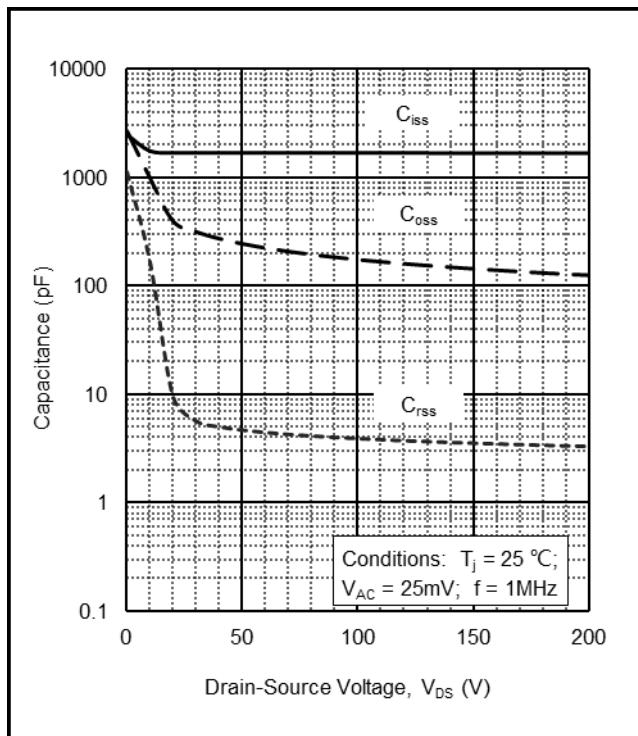


Figure 17. Capacitance vs. drain-source voltage  
 (0 - 200V)

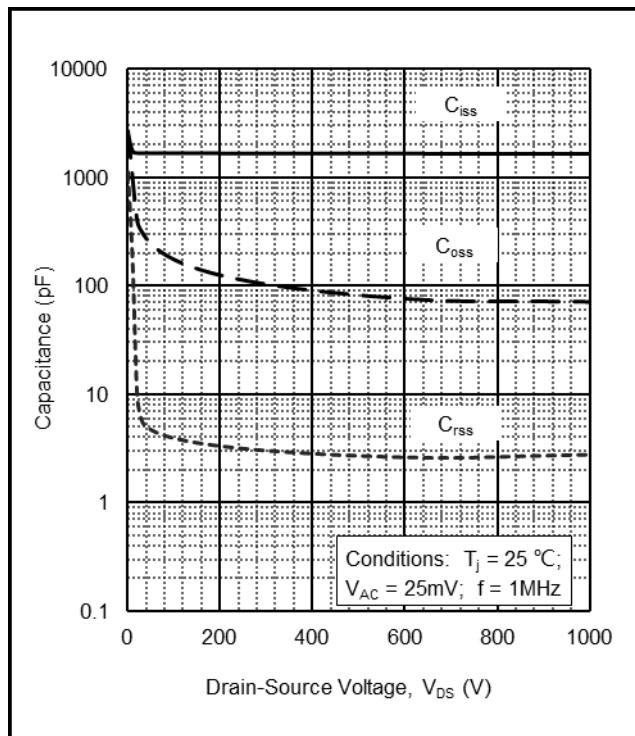


Figure 18. Capacitance vs. drain-source voltage  
 (0 - 1000V)

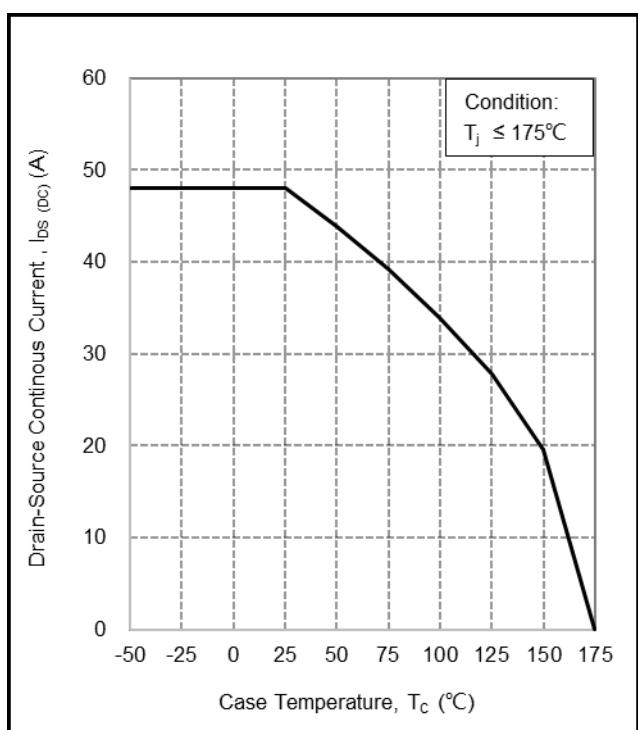


Figure 19. Continuous drain current derating  
 vs. temperature

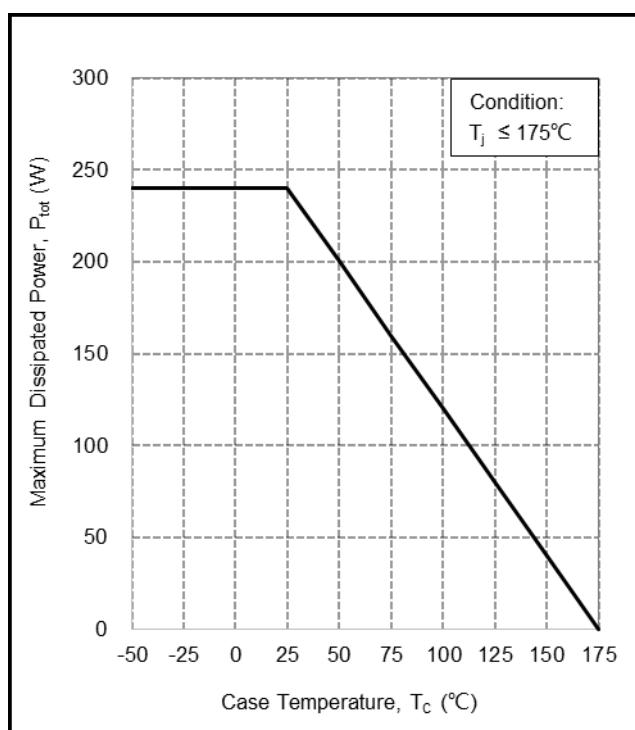


Figure 20. Maximum power dissipation derating  
 vs. temperature

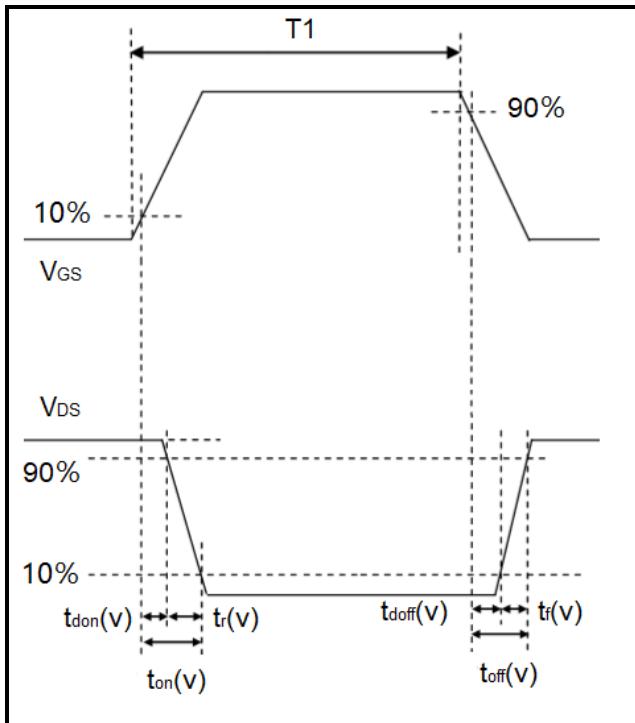
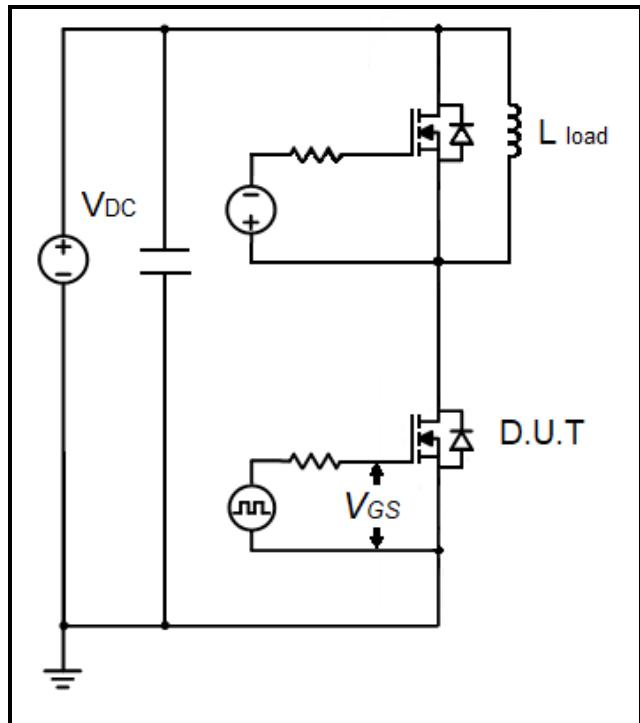
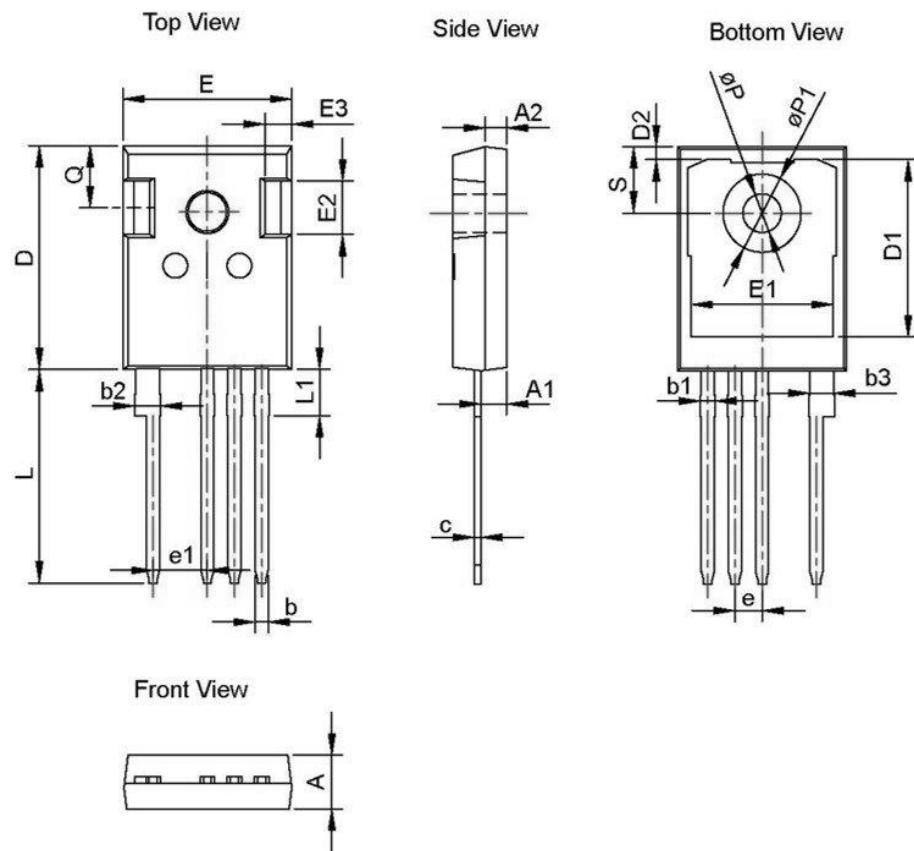


Figure 21. Switching times definition


 Figure 22. Clamped inductive switching waveform  
 test circuit

## Package Information

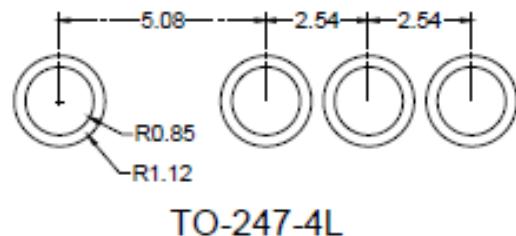


Dimension unit: [mm]			
Symbol	Min	Nom	Max
A	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b1	1.11	1.37	1.57
b2	2.24	2.40	2.60
b3	2.11	2.21	2.36
c	0.51	0.60	0.75
D	20.70	20.90	21.30
D1	15.92	16.22	16.52
D2	1.00	1.20	1.35
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	2.54 BSC		
e1	5.08 BSC		

Dimension unit: [mm]			
Symbol	Min	Nom	Max
L	19.62	19.92	20.22
L1	-	-	4.30
ØP	3.40	3.60	3.80
ØP1	-	-	7.30
Q	5.40	5.80	6.20
S	6.20 BSC		

## Recommended Solder Pad Layout

Note: All dimensions are in mm



## Ordering Information

Part number	SMS1200040M2-ISATH
Package	TO-247-4L
Unit quantity	300 EA
Packing type	Tube

## Important Notices – Read Carefully

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